Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/745,606	NISHIKAWA ET AL.	
	Examiner	Art Unit	
	Annan Q. Shang	2617	

SEARCHED			
Class	Subclass	Date	Examiner
725	38-61	10/25/2005	A.S.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR